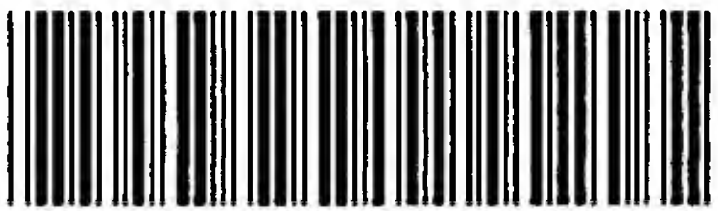


<b>Search Notes</b>  	<b>Application/Control No.</b>  10709145	<b>Applicant(s)/Patent Under Reexamination</b>  HAGBERG ET AL.
	<b>Examiner</b>  Kaplan, Hal I	<b>Art Unit</b>  2836

SEARCHED			
Class	Subclass	Date	Examiner
307	10.8	7/27/2007	HK
200	179	7/27/2007	HK
200	519	7/27/2007	HK
200	523	7/27/2007	HK
200	524	7/27/2007	HK
200	525	7/27/2007	HK
200	256	7/27/2007	HK
200	527	7/27/2007	HK
200	528	7/27/2007	HK

SEARCH NOTES		
Search Notes	Date	Examiner
307/9.1,10.1,10.8,40 (consulted Robert DeBeradinis)	2/28/2006	HK
315/77,82,83 (consulted Haissa Philogene)	2/28/2006	HK
180/\$ (consulted Frank Vanaman) - no search	3/1/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	7/25/2007	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	7/26/2007	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	7/27/2007	HK
200/4,5R,6A,14,17R,18 (consulted Michael Friedhofer)	8/20/2007	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	8/22/2007	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner